

<b>Notice of References Cited</b>			Application/Control No. 09/839,972	Applicant(s)/Patent Under Reexamination BODNAR ET AL.	
			Examiner Huy Q. Phan	Art Unit 2617	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,993,497 B2	01-2006	Yeh et al.	705/14
*	B	US-6,934,698 B2	08-2005	Judd et al.	707/1
*	C	US-7,015,806 B2	03-2006	Naidoo et al.	340/531
*	D	US-2003/0142215 A1	07-2003	WARD et al.	348/207.1
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.